# Non traditional manufacturing processes (2)

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## Photolithography

 Uses light radiation to expose a coating of photoresist on the surface of the wafer

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- Common light source in wafer processing is ultraviolet light, due to its short wavelength
- A mask containing the required geometric pattern for each layer separates the light source from the wafer, so that only the portions of the photoresist not blocked by the mask are exposed

http://www.youtube.com/watch?v=aCO yq4YzBtY&feature=related







## **Photolithography Mask**

- Flat plate of transparent glass onto which a thin film of an opaque substance has been deposited in certain areas to form the desired pattern
- The mask itself is fabricated by lithography, the pattern being based on circuit design data, usually in the form of digital output from the CAD system used by circuit designer



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## **Photoresist**

- Organic polymer that is sensitive to light radiation in a certain wavelength range
- Sensitivity causes either increase or decrease in solubility of the polymer to certain chemicals
- Typical practice in semiconductor processing is to use photoresists sensitive to UV light
  - UV light has a short wavelength compared to visible light, permitting sharper imaging of circuit details on wafer surface
- Also permits fabrication areas in plant to be illuminated at low light levels outside UV band

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## **Photoresist Spin Coating**

- Wafer is held on a spinner chuck by vacuum and resist is coated to uniform thickness by spin coating.
- Typically 3000-6000 rpm for 15-30 seconds.
- Resist thickness is set by:
  - primarily resist viscosity
  - secondarily spinner rotational speed
- Resist thickness is given by  $t = kp^2/w^{1/2}$ , where
  - k = spinner constant, typically 80-100
  - p = resist solids content in percent
  - w = spinner rotational speed in rpm/1000
- Most resist thicknesses are 1-2 µm for commercial Si processes

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## **Photoresist Spin Coating**



## **Stages of Resist Coating**



## Prebake (Soft Bake)

- Used to evaporate the coating solvent and to densify the resist after spin coating.
- Typical thermal cycles:
  - 90-100°C for 20 min. in a convection oven
  - 75-85°C for 45 sec. on a hot plate
- Commercially, microwave heating or IR lamps are also used in production lines.
- Hot plating the resist is usually faster, more controllable, and does not trap solvent like convection oven baking.



#### **Overview of Align/Expose/Develop Steps**



#### **Alignment and Exposure Hardware**



## Postbake (Hard Bake)

- Used to stabilize and harden the developed photoresist prior to processing steps that the resist will mask.
- Main parameter is the plastic flow or glass transition temperature.
- Postbake removes any remaining traces of the coating solvent or developer.
- This eliminates the solvent burst effects in vacuum processing.
- Postbake introduces some stress into the photoresist.
- Some shrinkage of the photoresist may occur.
- Longer or hotter postbake makes resist removal much more difficult.
  <u>http://www.youtube.com/watch?v=9x3Lh1ZfggM</u>

http://www.youtube.com/watch?v=63SPa0Lx9-c

Iniversitv

# **Photoresist Removal (Stripping)**

- Want to remove the photoresist and any of its residues.
- Simple solvents are generally sufficient for nonpostbaked photoresists:
  - Positive photoresists:
    - acetone
    - trichloroethylene (TCE)
    - phenol-based strippers (Indus-Ri-Chem J-100)
  - Negative photoresists:
    - methyl ethyl ketone (MEK), CH3COC2H5
    - methyl isobutyl ketone (MIBK), CH3COC4H9
- Plasma etching with O2 (ashing) is also effective for removing organic polymer debris.

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#### **Basics of Photolithography for Processing**

- Microfabrication processes:
  - Additive  $\rightarrow$  deposition
  - Subtractive  $\rightarrow$  etching
  - Modifying  $\rightarrow$  doping, annealing, or curing
- Two primary techniques for patterning additive and subtractive processes:
  - Etch-back:
  - photoresist is applied overtop of the layer to be patterned
  - unwanted material is etched away
  - Lift-off:
  - patterned layer is deposited over top of the photoresist
  - unwanted material is lifted off when resist is removed

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## **Etch-back**



## Lift-off



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#### **Photolithography process and limitation**



# Limitation of Photolitho. In Display

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- Increase of demands for nano/micro scale patterns with large pattern area
- Large-size substrate in digital display





#### [Glass substrate generation]

•	2,200 mm		Gen 7
•	1,800 mm	Gen 6	
<b>↓</b> 1,300	mm Gen 5		
<mark>∢ 920 m</mark>	m Gen 4		
Gen 2	Gen 3		
Gen 1			

#### [Glass size 1950 X 2250mm]



- Accomplishment of 7th generation display above 40"
  - → Requirement for replication of large area pattern
  - Limitation in conventional micro/nano technology
- Expensive lithography system for large area pattering

- Expensive process



## **Nano-replication**



## **Thermal nano-imprinting**

Procedures



# **UV** nano-imprinting

#### UV nano-imprinting

- Material: UV-curable photopolymer
- Processing condition: room temp. & low pressure

on substrate

• No fluidity problem

Photopolymer

Procedures 

Substrate



# **Continuous UV nano-imprinting**

Design and construction of continuous UV nano imprinting system



Continuous UV nano-imprinting system



Fabrication results



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1. Can replicate nano patterns of large area with high precision

2. Can replace conventional lithography process

#### Nano-Imprinting 기술의 응용분야 1.

#### 특수한 기능을 가진 자연물의 모사





<u> 연꽃 잎</u>



자료출처: http://blog.empas.com/bl1vgt/\_Manbui Sun\_Langmuir, Vol.21, 여명 Ang University L. Feng, Advanced Material,Vol.14, pp.1857, 2002 Alexander Otten, Langmuir, Vol.20, pp.2405, 2004

# 물에 젖지 않는 자연물들 (2)



자료축처·Woo Lee et at al., Langmuir, Vol 20, pp. 7665, 2004 Xuefeng Gao et at al., Nature, Vol.432, pp. 36, 2004 - CAVE Department of Mechanical Engineering Chung-Ang University

## 물에 젖지 않는 표면의 제작





으요 브아



<자동차>



자료출처: Manhui Sun et at al..langmuir. vol.21. pp.8978. 2005 Woo Lee et at al., Langmuir, Vol.20, pp.7665, 2004 http://www.dumitrup.com/blog/

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## 어떤 곳이든지 붙을 수 있는 발바닥



http://news.bbc.co.uk/2/而怎cience/nature/781611.stm

## 어떤 곳이든지 붙을 수 있는 표면의 제작



http://bdml.stanford.edu/twiki/bin/view/Main/StickyBot

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## 빛이 반사하지 않는 표면



자르출처·http://www.motheye.com/

http://blog.empas.com/squirrel1226/

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## 빛이 반사하지 않는 표면의 제작



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## 유체의 저항을 줄이는 표면



## 유체 저항을 줄이는 표면의 제작

#### ■상어 피부





<Drag reduction of surface>

#### ■상어 피부 형상의 응용 - 수영복



<Speed speedo Fastskin II>
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## 특정 파장의 빛을 반사하는 표면







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#### Nano-Imprinting 기술의 응용분야 2.

Electronics



## **Photonic IC**



World's Fastest Optical Chip wavelength division multiplexing (WDM)

Concept of photonic IC

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## **Patterned Media**





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#### Nano-Imprinting 기술의 응용분야 3.

#### **Bio Application**



## Lab on a chip & Bio sensor







Micro-Cantilever biosensor



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## Scaffold tissue engineering



